

# M02016

## CMOS PIN Pre-amplifier with AGC for Fiber-optics Based Networks up to 1.25 Gbps Data Sheet

Preliminary Information

CMOS PIN Pre-amplifier with AGC for Fiber-optics Based Networks up to 1.25 Gbps

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**FEATURES**

- ❑ Typical -27 dBm sensitivity, +3 dBm saturation at 1.25 Gbps when used with 0.9 A/W InGaAs PINs. (Cpd ≤ 1.0 pF BER 10<sup>-10</sup>)
- ❑ Typical differential transimpedance: 30 kΩ
- ❑ Fabricated in standard CMOS
- ❑ Differential output
- ❑ Standard +3.3 Volt supply
- ❑ Available in die form only
- ❑ Monitor output
- ❑ AGC provides dynamic range of more than 30 dBm

**APPLICATIONS**

- ❑ ATM/SDH/SONET
- ❑ Gigabit Ethernet
- ❑ Fiber Channel

**DESCRIPTION**

The M02016 is a CMOS transimpedance amplifier with AGC. The AGC allows more than 30 dBm dynamic range. The high transimpedance gain gives good sensitivity.

For optimum system performance, the M02016 die should be mounted with a silicon or InGaAs PIN photodetector inside a lensed TO-Can or other optical sub-assembly.

The M02016 reverse biases the PIN by approximately 1.8 volts to optimize the PINs performance.

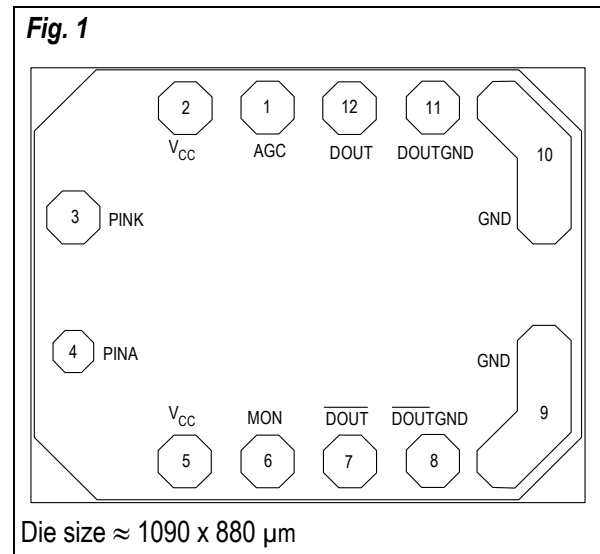
A replica of the average photodiode current is available at the MON pad for photo-alignment and 'LOSS of SIGNAL' monitoring.

**TABLE 1 ORDERING INFORMATION**

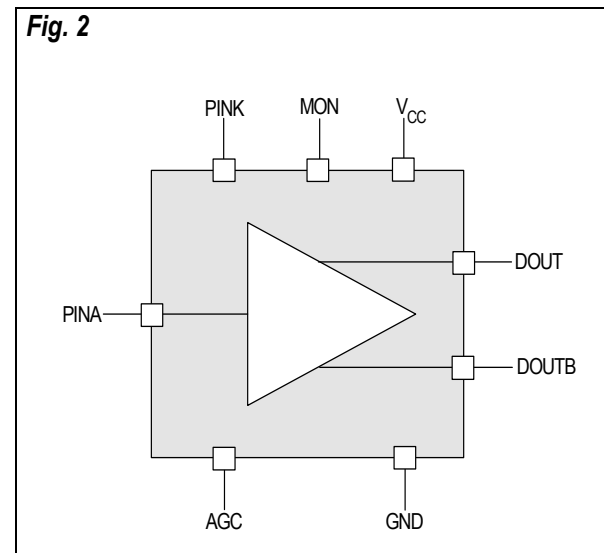
| Part       | Pin Package                    |
|------------|--------------------------------|
| M02016-XX* | Waffle Pack                    |
| M02016-XX* | Expanded whole wafer on a ring |

\*For full ordering number please contact sales

**CONNECTIONS**



**TOP LEVEL DIAGRAM**



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TABLE 2 \_\_\_\_\_ PAD DESCRIPTION

| Die Pad No | Name                 | Function   |
|------------|----------------------|--|
| 1          | AGC                  | Monitor or force AGC voltage. Enable self test oscillator when $V_{AGC} > V_{CC} + 1.2$            |
| 2          | $V_{CC}$             | Power pin. Connect to most positive supply   |
| 3          | PINK                 | AC common PIN input. Connect photo diode cathode here and a 470 pF capacitor to Gnd <sup>(1)</sup> |
| 4          | PINA                 | Active PIN input. Connect photo diode anode here   |
| 5          | $V_{CC}$             | Power pin. Connect to most positive supply (only one $V_{CC}$ pad needs to be connected)           |
| 6          | MON                  | Analog current sink output. Current matched to average photodiode current                          |
| 7          | $\overline{DOUT}$    | Differential data output (goes low as light increases)   |
| 8          | $\overline{DOUTGND}$ | Ground return for $\overline{DOUT}$ pad (all GND pads must be connected)                           |
| 9          | GND                  | Ground pin. Connect to the most negative supply (all GND pads must be connected)                   |
| 10         | GND                  | Ground pin. Connect to the most negative supply (all GND pads must be connected)                   |
| 11         | $\overline{DOUTGND}$ | Ground return for $\overline{DOUT}$ pad (all GND pads must be connected)                           |
| 12         | DOUT                 | Differential data output (goes high as light increases)  |
| NA         | Backside             | Backside. Connect to the lowest potential, usually ground  |

Note: (1) Alternatively the photodiode cathode may be connected to a decoupled positive supply e.g.  $V_{CC}$ .

TABLE 3 \_\_\_\_\_ ABSOLUTE MAXIMUM RATINGS

| Symbol    | Parameter                     | Rating      | Units |
|-----------|-------------------------------|-------------|-------|
| $V_{CC}$  | Power supply ( $V_{CC}$ -GND) | 4           | V     |
| $T_A$     | Operating ambient             | -40 to +85  | °C    |
| $T_{STG}$ | Storage temperature           | -65 to +150 | °C    |

TABLE 4 \_\_\_\_\_ RECOMMENDED OPERATING CONDITIONS

| Symbol   | Parameter   | Rating         | Units |
|----------|---|----------------|-------|
| $V_{CC}$ | Power supply ( $V_{CC}$ -GND)   | $3.3 \pm 10\%$ | V     |
| $C_{PD}$ | Max. Photodiode capacitance ( $V_f = 1.8$ V), for 1.25 Gbps data rate | 1.0            | pF    |
| $T_A$    | Operating ambient temperature   | -40 to +85     | °C    |

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TABLE 5 \_\_\_\_\_ DC CHARACTERISTICS

| Symbol                              | Parameter                               | Min. | Typ.               | Max. | Units |
|-------------------------------------|---|------|--------------------|------|-------|
| V <sub>B</sub>                      | Photodiode bias voltage (PINK - PINA)   | 1.6  | 1.8                | 2    | V     |
| V <sub>CM</sub>                     | Common mode output voltage              | 0.7  | 1                  | 1.3  | V     |
| V <sub>OL</sub> and V <sub>OH</sub> | Output voltage swing                    | .45  | 1                  | 1.55 | V     |
| I <sub>CC</sub>                     | Supply current (no loads)               | 23   | 30                 | 39   | mA    |
| R <sub>LOAD</sub>                   | Recommended differential output loading | 85   | 100 <sup>(1)</sup> | -    | Ω     |

NOTE <sup>(1)</sup> 100Ω is the load presented by the input of the Mindspeed M02040 limiting amplifier.

TABLE 6 \_\_\_\_\_ AC CHARACTERISTICS

| Symbol              | Parameter  | Min. | Typ. <sup>(2)</sup> | Max. | Units   |
|---------------------|--|------|---------------------|------|---------|
| R <sub>OUT</sub>    | Output impedance (single ended)                              | 25   | 40                  | 60   | Ω       |
| LFC                 | Low frequency cutoff   | 30   | 50                  | 110  | KHz     |
| V <sub>D</sub>      | Differential output voltage                                  | -    | 275                 | 500  | mV      |
| DCD                 | Duty cycle distortion  | -    | -                   | 20   | ps      |
| DJ                  | Deterministic jitter (includes DCD)                          | -    | -                   | 40   | ps, p-p |
| I <sub>n, rms</sub> | Total input RMS noise, DC to 1 GHz, C <sub>in</sub> = 1.0 pF | -    | 210                 | 300  | nA      |
| Pin                 | Example dynamic range of optical input <sup>3</sup>          | -26  | -                   | +3   | dBm     |
| PIN (mean), min     | Optical Sensitivity <sup>3</sup>                             | -    | -27                 | -    | dBm     |

NOTE <sup>(2)</sup> Die designed to operate over an ambient temperature range of -40 °C to +85 °C, T<sub>A</sub> and V<sub>CC</sub> range from 3.0 - 3.6V. Typical values are tested at T<sub>A</sub> = 25° C and V<sub>CC</sub> = 3.3V.

NOTE <sup>(3)</sup> BER 10<sup>-10</sup>, PD capacitance = 1.0 pF, Responsivity 0.9 A/W, Extinction Ratio = 10.

TABLE 7 \_\_\_\_\_ DYNAMIC CHARACTERISTICS

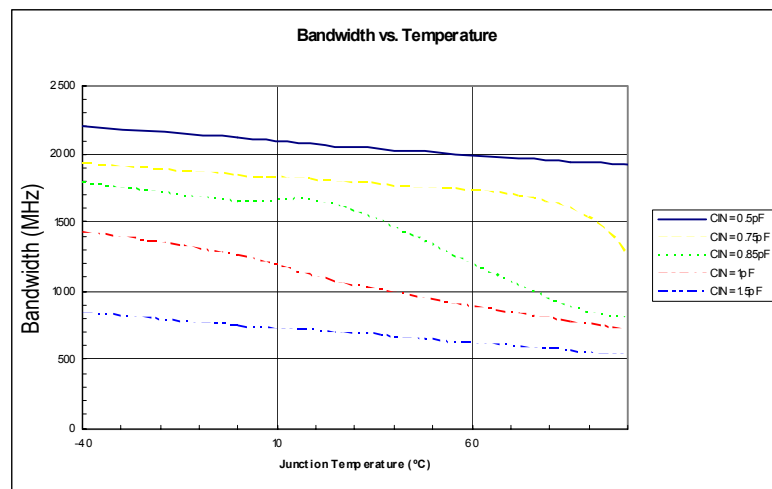
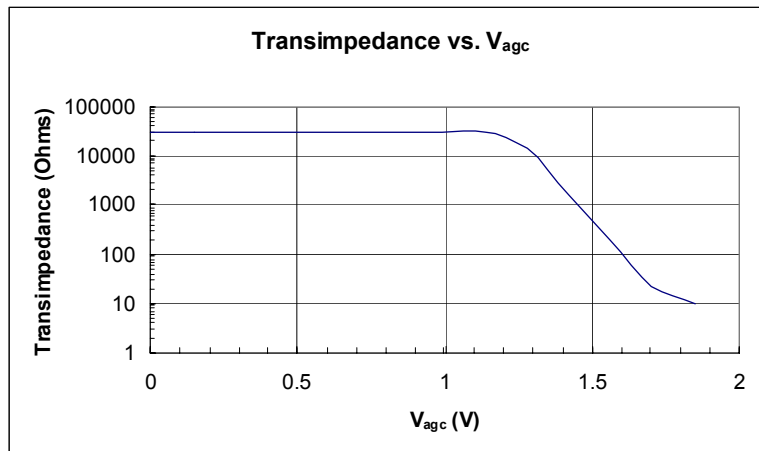
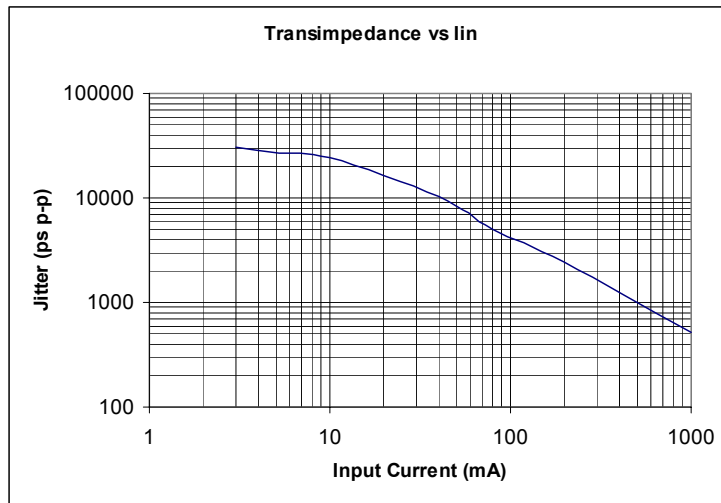
| Symbol           | Parameter   | Min.     | Typ.     | Max.       | Units   |
|------------------|---|----------|----------|------------|---------|
| G                | Transimpedance<br>- Single ended<br>- Differential    | 12<br>24 | 15<br>30 | 17.5<br>35 | KΩ      |
| BW               | Bandwidth to -3 dB point @ -26 dBm, 0.9A/W, 1.0 pF PD | 0.7      | 1.1      | -          | GHz     |
| RC               | AGC loop time constant                                | -        | 2        | -          | μs      |
| I <sub>AGC</sub> | AGC threshold   | 9        | 11       |            | μA, p-p |
| PSRR             | Power supply rejection, f < 4 MHz                     | 20       | 28       | -          | dB      |

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TYPICAL PERFORMANCE

Fig. 3.  $V_{cc} = 3.3V$ , Temperature = 25 °C,  $L_{in} = 1 nH$ , unless otherwise stated.

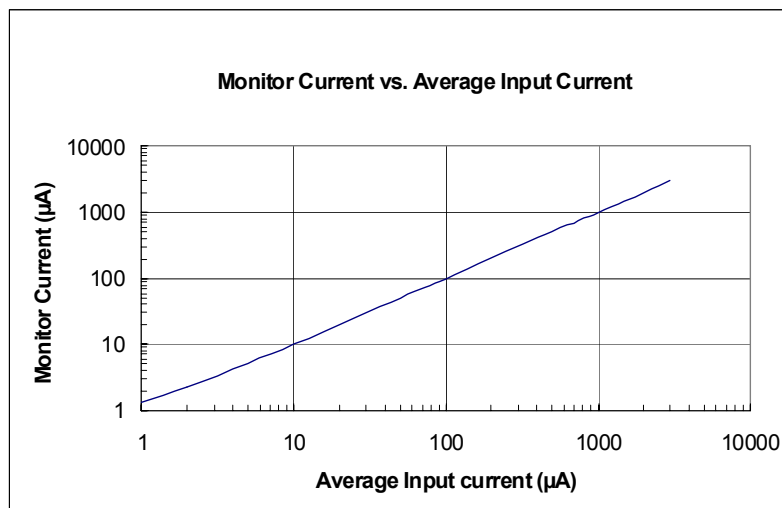
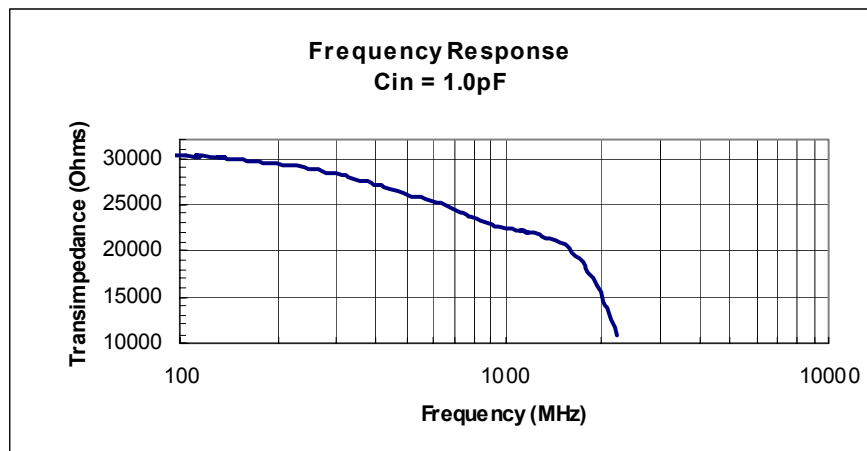
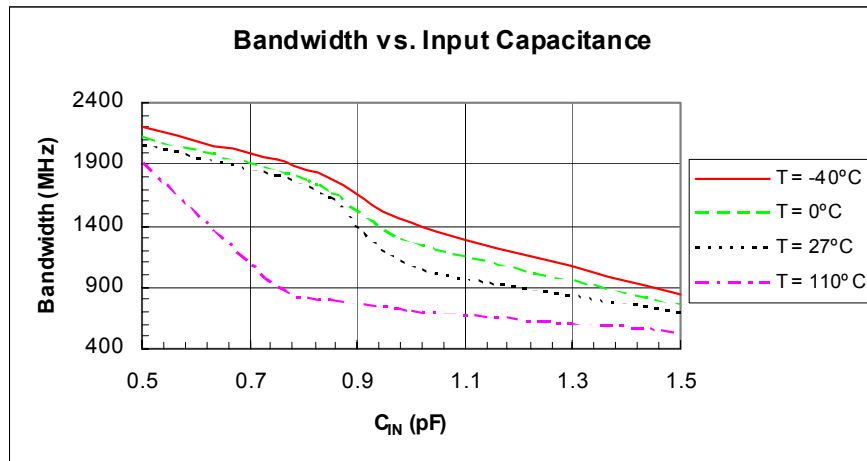


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TYPICAL PERFORMANCE (CONT.)

Fig. 3 (cont.)

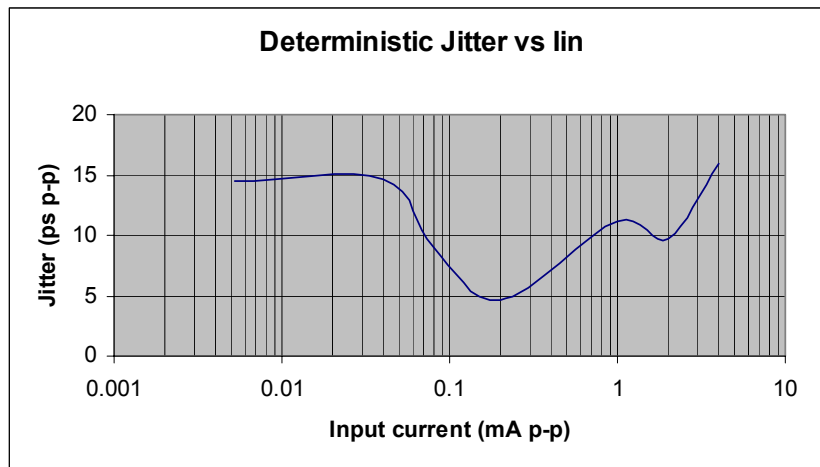
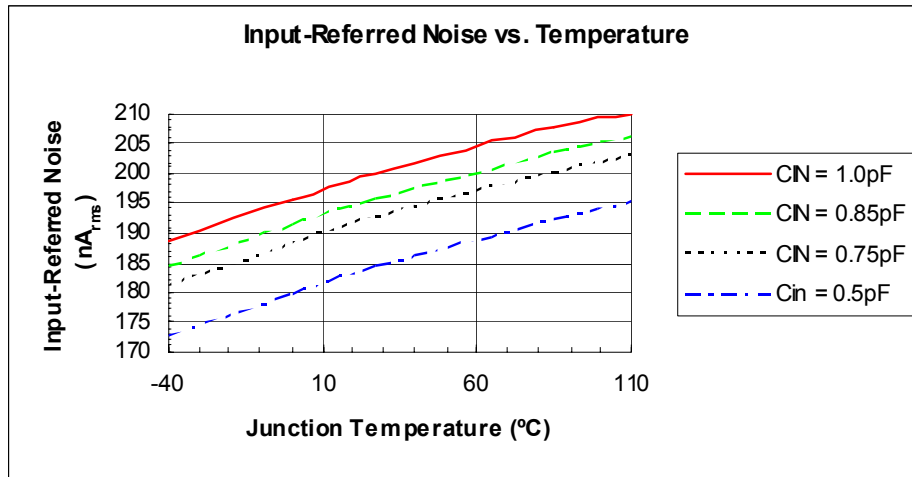


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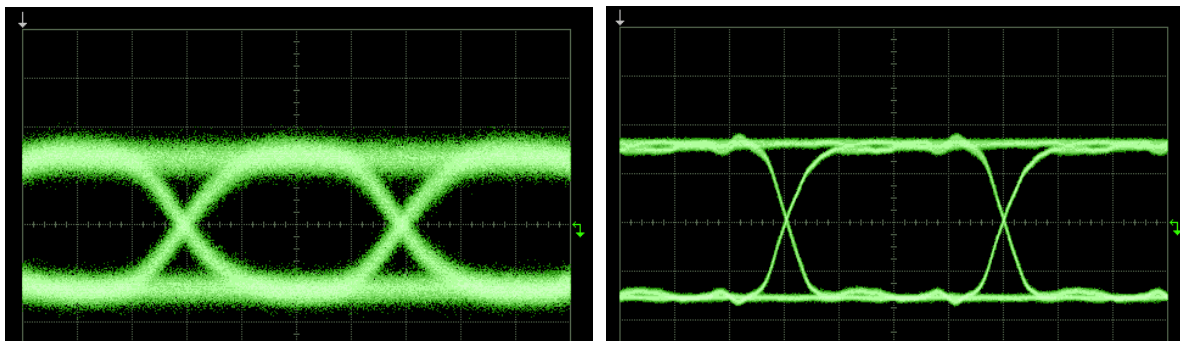
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TYPICAL PERFORMANCE (CONT.)

Fig. 3 (cont.)



Eye Diagrams for 1.25 Gb/s at -27 dBm and 0 dBm Input Signals

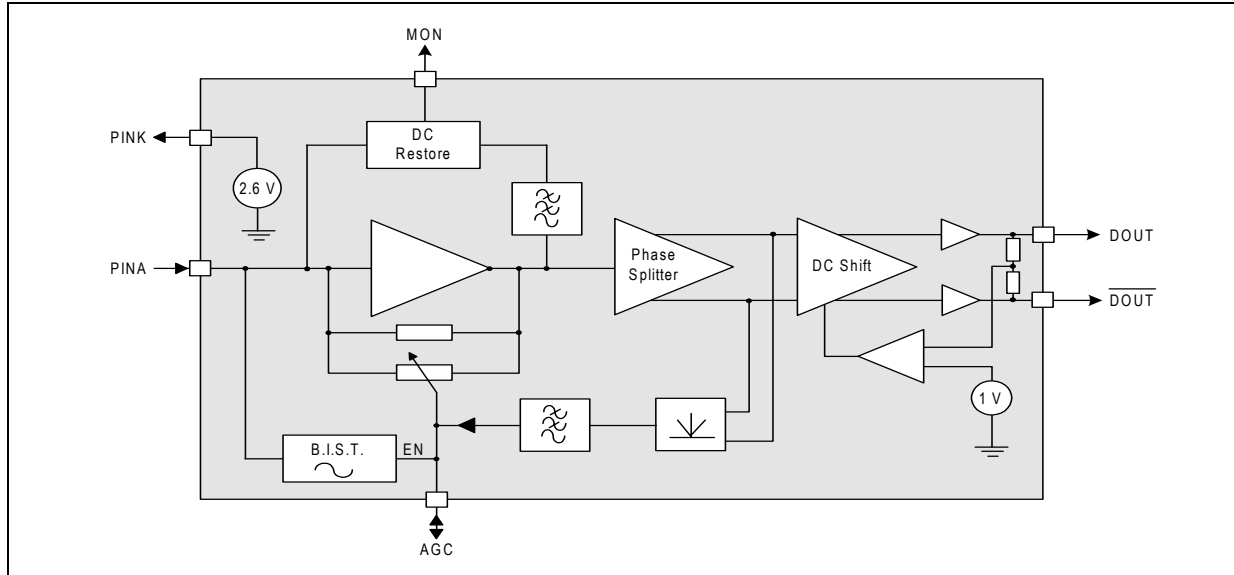


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FUNCTIONAL DIAGRAM



FUNCTIONAL DESCRIPTION

Preliminary Information

**TIA (Transimpedance Amplifier)**

The transimpedance amplifier consists of a high gain single-ended CMOS amplifier (TIA), with a feedback resistor. The feedback creates a virtual earth low impedance at the input and virtually all of the input current passes through the feedback resistor, defining the voltage at the output. Advanced CMOS design techniques are employed to maintain the stability of this stage across all input conditions.

Single-ended amplifiers have inherently poor power supply noise rejection. For this reason, an on-chip low dropout linear regulator has been incorporated into the design to give excellent noise rejection up to several MHz. Higher frequency power supply noise is removed by the external 470 pF decoupling capacitor connected to PINK.

The circuit is designed for PIN photodiodes in the “grounded cathode” configuration, with the anode connected to the input of the TIA and the cathode connected to AC ground, such as the provided PINK terminal. Reverse DC bias is applied to reduce the photodiode capacitance. Avalanche photodiodes can be connected externally to a higher voltage.

**AGC**

The M02016 has been designed to operate over the input range of +3 dBm to -27 dBm. This represents a ratio of 1:1000, whereas the acceptable dynamic range of the output is only 1:30 which implies a compression of 33:1 in the transimpedance. The design uses a MOS transistor operating in the triode region as a “voltage controlled resistor” to achieve the transimpedance variation.

Another feature of the AGC is that it only operates on signals greater than -22 dBm (@ 0.9 A/W). This knee in the gain response is important when setting “signal detect” functions in the following post amplifier. It also aids in active photodiode alignment.

The AGC pad allows the AGC to be disabled during photodiode alignment by grounding the pad through a low impedance. The AGC control voltage can be monitored during normal operation at this pad by a high impedance (>10 MΩ) circuit. In addition, taking this pad to V<sub>CC</sub> +1.2 V enables an internal test oscillator which supplies a 1 MHz 10 μApp (approximate) square wave current internally into the PINA pad to emulate a photodiode for test purposes.

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FUNCTIONAL DESCRIPTION

**Output Stage**

The signal from the TIA enters a phase splitter followed by a DC-shift stage and a pair of voltage follower outputs. These are designed to drive a differential (100 Ω) load. They are stable for driving capacitive loads, such as interstage filters. Each output has its own GND pad, all four GND pads on the chip should be connected for

proper operation. Since the M02016 exhibits rapid roll-off (3 pole), simple external filtering is sufficient.

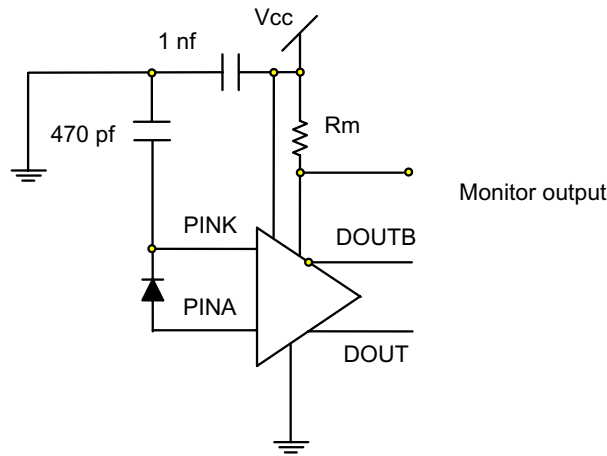
**Monitor O/P**

High impedance O/P sinks replicate average photodiode current for monitoring purposes.

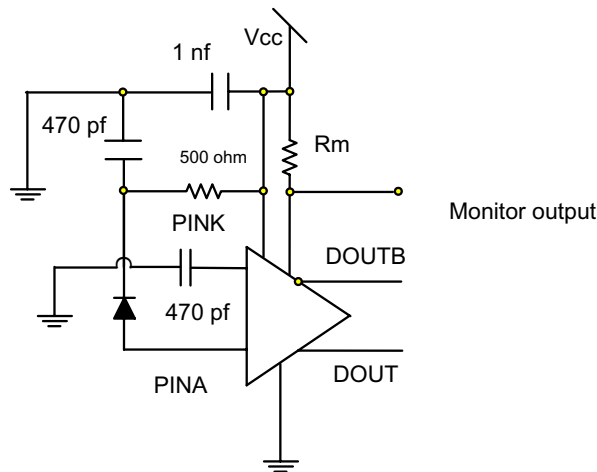
SUGGESTED PIN DIODE CONNECTION METHODS

Preliminary Information

Fig. 5



Recommended Circuit

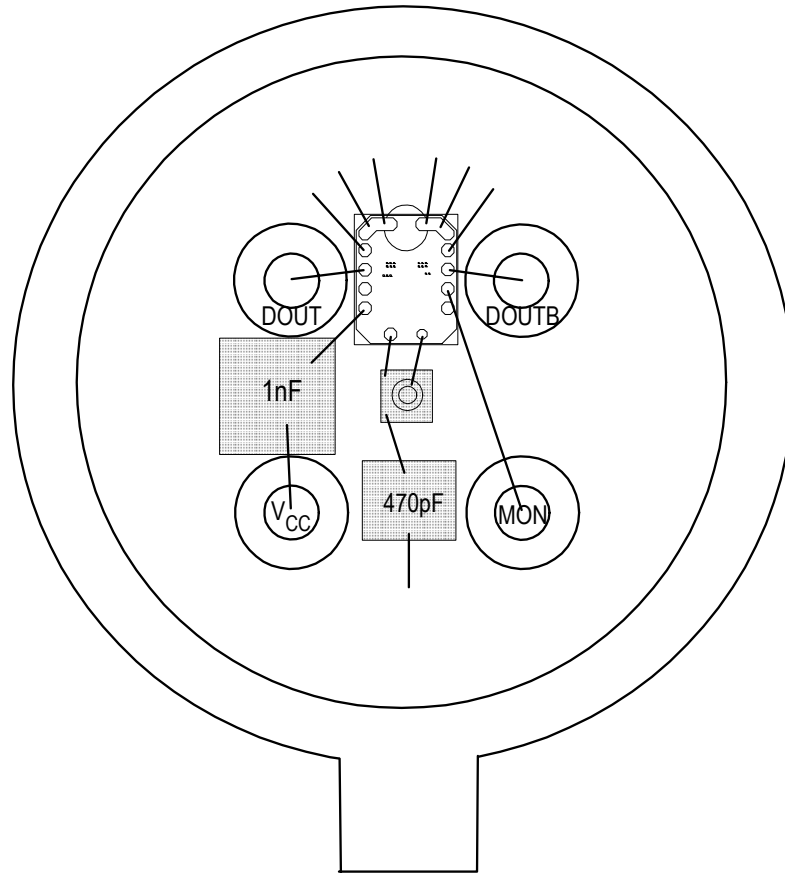


Alternative Circuit (Cathode Connected to Vcc)

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TYPICAL APPLICATION DIAGRAM

Fig. 6



**Notes:**

Typical application inside of a five lead TO-Can.

Only one of the  $V_{CC}$  pads and all of the GND pads need to be connected. The backside must be connected to the lowest potential, usually ground, with conductive epoxy or a similar die attach material.

**Assembly**

The M02016 is designed to work with a wirebond inductance of 1 nh +/- 0.25 nh. Many existing TO-Can configurations will not allow wirebond lengths that short, since the PIN diode submount and the TIA die are more than 1 mm away in the vertical direction, due to the need to have the PIN diode in the correct focal plane. This can be remediated by raising up the TIA die with a conductive metal shim. This will effectively reduce the bond wire length. Refer to Figure 5 on the following page for details. Mindspeed recommends ball bonding with a 1 mil (24.4  $\mu$ m) gold wire.

In addition, please refer to the Mindspeed Product Bulletin (document number 0201X-PBD-001). Care must be taken when selecting chip capacitors, since they must have good low ESR characteristics up to 1.0 Ghz. It is also important that the termination materials of the capacitor be compatible with the attach method used.

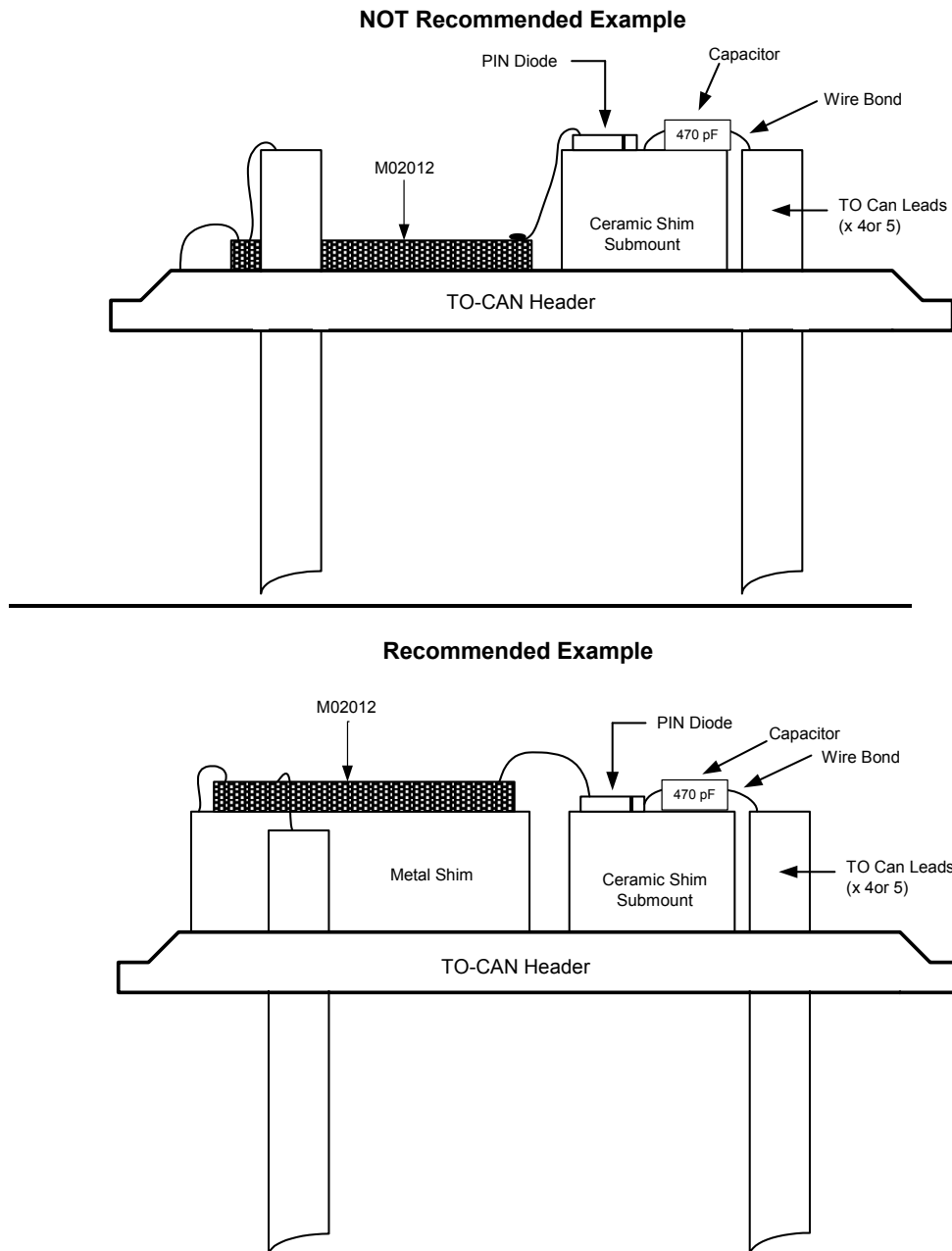
For example, Tin/Lead (Pb/Sn) solder finish capacitors are incompatible with silver-filled epoxies. Palladium/Silver (Pd/Ag) terminations are compatible with silver filled epoxies. Solder can be used only if the substrate thick-film inks are compatible with Pb/Sn solders.

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TO-CAN ASSEMBLY DIAGRAM

Fig. 7



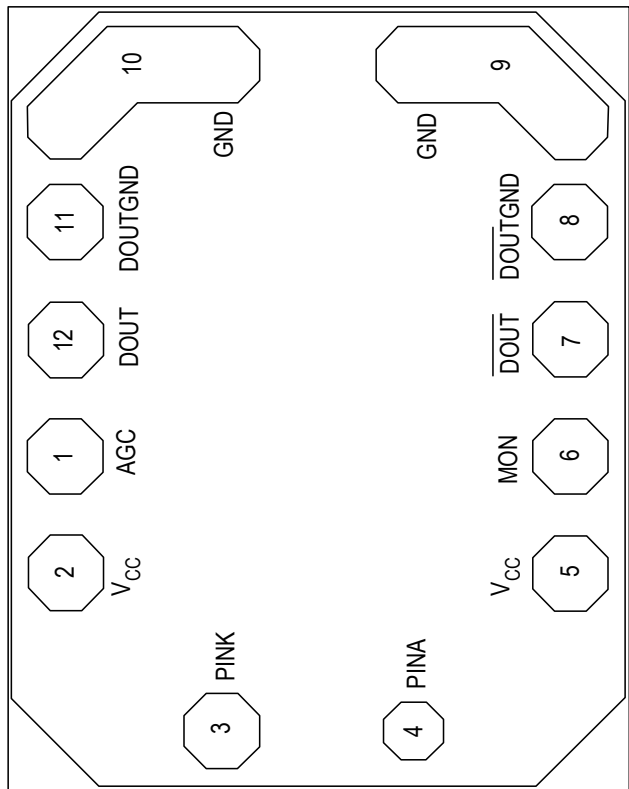
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BARE DIE INFORMATION

BARE DIE LAYOUT

Fig. 8



| Pad Number | Pad             | X    | Y    |
|------------|-----------------|------|------|
| 1          | AGC             | -76  | 329  |
| 2          | V <sub>CC</sub> | -228 | 329  |
| 3          | PINK            | -434 | 124  |
| 4          | PINA            | -434 | -124 |
| 5          | V <sub>CC</sub> | -228 | -329 |
| 6          | MON             | -76  | -329 |
| 7          | DOUT            | 76   | -329 |
| 8          | DOUTGND         | 228  | -329 |
| 9c*        | GND             | 360  | -329 |
| 9b*        | GND             | 434  | -255 |
| 9a*        | GND             | 434  | -124 |
| 10a*       | GND             | 434  | 124  |
| 10b*       | GND             | 434  | 255  |
| 10c*       | GND             | 360  | 329  |
| 11         | DOUTGND         | 228  | 329  |
| 12         | DOUT            | 76   | 329  |

Notes:

- Process technology: CMOS, Silicon Nitride passivation
- Die thickness: 300 μm
- Pad metallization: Aluminum
- Die size: 1090 μm x 880 μm
- Pad opening: 86 μmsq
- Octagonal pad: 70 μm across flat PINA (70 μm x 70 μm)
- Pad Centers in μm referenced to center of device
- Backside bias to ground

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